Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/670,194	KIMURA ET AL.
Examiner	Art Unit
Junghwa M. Im	2811

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
	Subclass	Subclass Date			

SEARCH NOT (INCLUDING SEARCH))
	DATE	EXMR
EAST (uspat, uspub, epo, jpo, der, ibm)	2/3/2006	JMI
text search: see search history printout	2/3/2006	JMI